

Re: Approval of Draft Indian Standards for Adoption for LITD 03, 22, 17, 01 and 33

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 Fri, 09 Aug 2024 2:41:04 PM +0530 •

To "Electronics and IT Department, BIS" <litd@bis.gov.in>

Cc "moona" <moona@iitgn.ac.in>, "Reena Garg, BIS" <hlitd@bis.gov.in>, "Alismita Khag" <litd01@bis.gov.in>, "litd22" <litd22@bis.gov.in>, "LITD ThirtyThree" <litd33@bis.gov.in>, "BIS Information Systems Security and Privacy Sectional Committee" <litd17@bis.gov.in>, "LTDtcTHREE Electronics and IT Department" <litd3@bis.gov.in>

Approved.

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Rajat Moona
 Director and
 Sudhir K. Jain Chair Professor
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On Thu, Aug 8, 2024 at 3:22 PM Electronics and IT Department, BIS <litd@bis.gov.in> wrote:

Dear Prof. Rajat Moona,
 Director IIT-Gandhinagar and Chairman – LITDC

Subject: Approval of Draft Indian Standards for Adoption for LITD 01, 03, 17,22, and 33

Sir,

In accordance with Sub Rule (5) of Rule 22 as per BIS Rules, 2018, Please find attached Indian Standards finalized by the

1. LITD 01-Environmental Testing Procedure Sectional Committee
2. LITD 03-Electromechanical Components And Mechanical Structures For Electronic--equipment Sectional Committee.
3. LITD 17-Information Systems Security And Privacy Sectional Committee
4. LITD 22 Geospatial Information Sectional Committee
5. LITD 33 Wearable electronic devices and technologies Sectional Committee

and After taking into account the comments received from important producers, operators, consumers technologists members of the Electronics and Information Technology Division Council and recorded in the minutes.

S.No.	Doc No.	IS No.	Title
1.	LITD 03 (23497)	IS/IEC 60512-2-3:2002	Connectors for electronic equipment Part 2 Tests and measurements Section 3: Electrical continuity and contact resistance tests Test 2c: Contact resistance variation
2.	LITD 22 (23730)	IS/ISO 19101-1:2014	Geographic Information Reference Model Part 1: Fundamentals
3.	LITD 03 (23495)	IS/IEC 60512-2-1: 2002	Connectors for electronic equipment Part 2 Tests and measurements Section 1: Electrical continuity and contact resistance tests Test 2a: Contact resistance Millivolt level method
4.	LITD 03 (23486)	IS/IEC 60512-4-2 : 2002	Connectors for electronic equipment Part -4 Tests and measurements Section - 2: Voltage stress tests - Test 4b: Partial discharge
5.	LITD 17 (24473)	IS/ISO/IEC 27036-3:2023	Cybersecurity Supplier Relationships Part 3: Guidelines for Hardware Software and Services Supply Chain Security
6.	LITD 33 (24136)	IS/IEC 63203-401-1:2023	Wearable electronic devices and technologies Part 401: Devices and systems: functional elements Section 1: Evaluation method of the stretchable resistive strain sensor
7.	LITD 01 (25092)	IS/IEC 60068-2-17:2023	Environmental Testing - Part 2 Tests – Section 17 Test Q: Sealing (First Revision)
8.	LITD 33 (24124)	IS/IEC 63203-101-1:2021	Wearable Electronic Devices and Technologies Part 101: Section1: Terminology
9.	LITD 33 (24132)	IS/IEC 63203-801-1:2022	Wearable electronic devices and technologies Part 801: Smart body area network SmartBAN Section 1: Enhanced ultra-low power physical layer

It is requested to accord your Approval for the adoption of the drafts as Indian Standard on behalf of the Electronics and Information Technology Division Council (LITDC).

Thanking you
With Kind Regards,
Reena Garg
Sc.G & Head (LITD)
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